

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10647540	NAPHADE ET AL.
	Examiner	Art Unit
	ALEX LIEW	2624

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
382 limited to text search	1/31/09	AL
382/117,181-231 limited to text search	7/27/09	AL

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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